

FuTuRe 2019 - Workshop on the Future of Silicon Detector Technologies

Monday 2 December 2019

Readout Electronics: Part I (09:40 - 10:40)

| time | [id] title | presenter |
|-------|------------|---------------------------|
| 09:40 | [13] tbd | Prof. YOSHIKAWA, Nobuyuki |
| 10:10 | [14] tbd | Mr HIRONAKA, Yoshi |

Readout Electronics: Part II (11:15 - 12:15)

| time | [id] title | presenter |
|-------|--|-----------------------|
| 11:15 | [15] Superconducting NbN Hot-Electron Bolometer as a Fast Diagnostic Tool for Accelerator Light Sources: System and Readout Design | Mr SCHMID, Alexander |
| 11:45 | [16] tbd | Prof. ORTLEPP, Thomas |